



Nonvolatile RAM Controller

MXD1210

General Description

The MXD1210 nonvolatile RAM controller is a very low-power CMOS circuit that converts standard (volatile) CMOS RAM into nonvolatile memory. It also continually monitors the power supply to provide RAM write protection when power to the RAM is in a marginal (out-of-tolerance) condition. When the power supply begins to fail, the RAM is write-protected, and the device switches to battery-backup mode.

Applications

- Microprocessor Systems
- Computers
- Embedded Systems

Pin Configurations



Features

- ◆ Battery Backup
- ◆ Memory Write Protection
- ◆ 230µA Operating Mode Quiescent Current
- ◆ 2nA Backup Mode Quiescent Current
- ◆ Battery Freshness Seal
- ◆ Optional Redundant Battery
- ◆ Low Forward-Voltage Drop on V_{CC} Supply Switch
- ◆ 5% or 10% Power-Fail Detection Options
- ◆ Tests Battery Condition During Power-Up
- ◆ 8-Pin SO Available

Ordering Information

| PART | TEMP RANGE | PIN-PACKAGE |
|------------|-----------------|-------------|
| MXD1210C/D | 0°C to +70°C | Dice* |
| MXD1210CPA | 0°C to +70°C | 8 PDIP |
| MXD1210CSA | 0°C to +70°C | 8 SO |
| MXD1210CWE | 0°C to +70°C | 16 Wide SO |
| MXD1210EPA | -40°C to +85°C | 8 PDIP |
| MXD1210ESA | -40°C to +85°C | 8 SO |
| MXD1210EWE | -40°C to +85°C | 16 Wide SO |
| MXD1210MJA | -55°C to +125°C | 8 CERDIP |

* Contact factory for dice specifications.

Devices in PDIP and SO packages are available in both leaded and lead-free packaging. Specify lead free by adding the + symbol at the end of the part number when ordering. Lead free not available for CERDIP package.

Typical Operating Circuit



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ABSOLUTE MAXIMUM RATINGS

| | | | |
|---|---|---|-----------------|
| V _{CCI} to GND | -0.3V to +7.0V | 8-Pin SO (derate 5.88mW/°C above +70°C)..... | 471mW |
| VBATT1 to GND..... | -0.3V to +7.0V | 8-Pin CERDIP (derate 8.00mW/°C above +70°C)..... | 640mW |
| VBATT2 to GND..... | -0.3V to +7.0V | 16-Pin Wide SO (derate 9.52mW/°C above +70°C) | 762mW |
| V _{CCO} to GND | -0.3V to (V _S + 0.3V) | Operating Temperature Range | |
| | (V _S = greater of V _{CCI} , VBATT1, VBATT2) | C Suffix..... | 0°C to +70°C |
| Digital Input and Output | | E Suffix..... | -40°C to +85°C |
| Voltages to GND..... | -0.3V to (V _{CCI} + 0.3V) | M Suffix | -55°C to +125°C |
| Continuous Power Dissipation (T _A = +70°C) | | Storage Temperature Range | -65°C to +150°C |
| 8-Pin PDIP (derate 9.09mW/°C above +70°C)..... | 727mW | Lead Temperature (soldering, 10s)..... | +300°C |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

(T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--------------------|------------------|---------------------------|------|-----|------|-------|
| Supply Voltage | V _{CCI} | TOL = GND | 4.75 | | 5.50 | V |
| | | TOL = V _{CCO} | 4.50 | | 5.50 | |
| Input High Voltage | V _{IH} | | 2.2 | | | V |
| Input Low Voltage | V _{IL} | | | | 0.8 | V |
| Battery Voltage | VBATT1 VBATT2 | 1 or 2 batteries (Note 1) | 2.0 | | 4.0 | V |

ELECTRICAL CHARACTERISTICS—Normal Supply Mode, TOL = V_{CCO}

(V_{CCI} = +4.75V to +5.5V, TOL = GND; or V_{CCI} = +4.5V to +5.5V, TOL = V_{CCO}; T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|-----------------------------|-------------------|--|----------|-------------------------|------|-------|
| Supply Current | I _{CCI} | V _{CCO} , \overline{CEO} open, VBATT1 = VBATT2 = 3V | | 0.23 | 0.5 | mA |
| Output Supply Voltage | V _{CCO} | I _{CCO1} = 80mA (Note 2) | MXD1210C | V _{CCI} - 0.20 | | V |
| | | | MXD1210E | V _{CCI} - 0.21 | | |
| | | | MXD1210M | V _{CCI} - 0.25 | | |
| Output Supply Current | I _{CCO} | V _{CCI} - V _{CCO} ≤ 0.2V (Note 2) | MXD1210C | | 80 | mA |
| | | | MXD1210E | 0.23 | 75 | |
| | | | MXD1210M | 0.23 | 65 | |
| Input Leakage Current | I _{IL} | | | | ±1.0 | μA |
| Output Leakage Current | I _{OL} | | | | ±1.0 | μA |
| High-Level Output Voltage | V _{OH} | I _{OH} = -1mA | 2.4 | | | V |
| Low-Level Output Voltage | V _{OL} | I _{OL} = 4mA | | | 0.4 | V |
| V _{CCI} Trip Point | V _{CCTP} | TOL = GND | 4.50 | | 4.74 | V |
| | | TOL = V _{CCO} | 4.25 | | 4.49 | |

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ELECTRICAL CHARACTERISTICS—Battery-Backup Mode

($V_{CCI} < V_{BATT}$, positive edge rate at V_{BATT1} , $V_{BATT2} > 0.1V/\mu s$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--------------------------------|------------|---|------------|------------------|-----|---------|
| Quiescent Current (Note 1) | I_{BATT} | V_{CCO} , \overline{CE} open, $V_{CCI} = 0V$ | | 2 | 100 | nA |
| | | | MXD1210C/E | | | |
| | | | | | 5 | μA |
| Output Supply Current | I_{CCO2} | $V_{BATT} - V_{CCO} \leq 0.2V$ (Notes 3, 4) | | | 300 | μA |
| \overline{CE} Output Voltage | V_O | Output open | | $V_{BATT} - 0.2$ | | V |

CAPACITANCE

($T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.) (Note 5)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--------------------|-----------|------------|-----|-----|-----|-------|
| Input Capacitance | C_{IN} | | | | 5 | pF |
| Output Capacitance | C_{OUT} | | | | 7 | pF |

V_{CC} POWER TIMING CHARACTERISTICS

($V_{CC} = +4.75V$ to $+5.5V$, $TOL = GND$; or $V_{CCI} = +4.5V$ to $+5.5V$, $TOL = V_{CCO}$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS | |
|------------------------------------|----------|---------------------------------|----------|-----|-----|-------|----|
| \overline{CE} Propagation Delay | t_{PD} | $R_L = 1k\Omega$, $C_L = 50pF$ | MXD1210C | 5 | 10 | 20 | ns |
| | | | MXD1210E | 5 | 10 | 22 | |
| | | | MXD1210M | 5 | 10 | 25 | |
| \overline{CE} High to Power-Fail | t_{PF} | (Note 5) | | 0 | | ns | |

TIMING CHARACTERISTICS

($V_{CC} < +4.75V$ to $+5.5V$, $TOL = GND$; or $V_{CCI} < +4.5V$, $TOL = V_{CCO}$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|-------------------------------|-----------|-------------------------------|-----|-----|-----|---------|
| Recovery at Power-Up | t_{REC} | | 2 | 5 | 20 | ms |
| V_{CC} Slew-Rate Power-Down | t_F | To out-of-tolerance condition | 300 | | | μs |
| | t_{FB} | Tolerance to battery power | 10 | | | |
| V_{CC} Slew-Rate Power-Up | t_R | | 0 | | | μs |
| \overline{CE} Pulse Width | t_{CE} | (Note 6) | | | 1.5 | μs |

Note 1: Only one battery input is required. Unused battery inputs must be grounded.

Note 2: I_{CCO1} is the maximum average load current the MXD1210 can supply to the memories.

Note 3: I_{CCO2} is the maximum average load current the MXD1210 can supply to the memories in battery-backup mode.

Note 4: \overline{CE} can sustain leakage current only in battery-backup mode.

Note 5: Guaranteed by design.

Note 6: t_{CE} max must be met to ensure data integrity on power loss.

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Pin Description

| PIN | | NAME | FUNCTION |
|---------------|----------------------------|-------------------------|--|
| 8-PIN PDIP/SO | 16-PIN WIDE SO | | |
| 1 | 2 | V _{CC0} | Backed-Up Supply to RAM |
| 2 | 4 | VBATT1 | Battery 1 Positive Connection |
| 3 | 6 | TOL | Tolerance Select Pin |
| 4 | 8 | GND | Ground |
| 5 | 9 | $\overline{\text{CE}}$ | Chip-Enable Input |
| 6 | 11 | $\overline{\text{CEO}}$ | Chip-Enable Output |
| 7 | 13 | VBATT2 | Battery 2 Positive Connection |
| 8 | 15 | V _{CC1} | 5V Power Supply to Chip |
| — | 1, 3, 5, 7, 10, 12, 14, 16 | N.C. | No Connection. Not internally connected. |



Figure 1. Block Diagram

Nonvolatile RAM Controller

Detailed Description

Main Functions

The MXD1210 executes five main functions to perform reliable RAM operation and battery backup (see the *Typical Operating Circuit* and Figure 1):

- 1) RAM Power-Supply Switch: The switch directs power to the RAM from the incoming supply or from the selected battery, whichever is at the greater voltage. The switch control uses the same criterion to direct power to MXD1210 internal circuitry.
- 2) Power-Failure Detection: The write-protection function is enabled when a power failure is detected. The power-failure detection range depends on the state of the TOL pin as follows:

| CONDITION | V _{CCTP} RANGE (V) |
|------------------------|-----------------------------|
| TOL = GND | 4.75 to 4.50 |
| TOL = V _{CCO} | 4.50 to 4.25 |

Power-failure detection is independent of the battery-backup function and precedes it sequentially as the power-supply voltage drops during a typical power failure.

- 3) Write Protection: This holds the chip-enable output (\overline{CEO}) to within 0.2V of V_{CCI} or of the selected battery, whichever is greater. If the chip-enable input (\overline{CE}) is low (active) when power failure is detected, then \overline{CEO} is held low until \overline{CE} is brought high, at which time \overline{CEO} is gated high for the duration of the power failure. The preceding sequence completes the current RD/WR cycle, preventing data corruption if the RAM access is a WR cycle.
- 4) Battery Redundancy: A second battery is optional. When two batteries are connected, the stronger battery is selected to provide RAM backup and to power the MXD1210. The battery-selection circuitry remains active while in the battery-backup mode, selecting the stronger bat-

tery and isolating the weaker one. The battery-selection activity is transparent to the user and the system. If only one battery is connected, the second battery input should be grounded.

- 5) Battery-Status Warning: This notifies the system when the stronger of the two batteries measures $\leq 2.0V$. Each time the MXD1210 is repowered (V_{CCI} > V_{CCTP}) after detecting a power failure, the battery voltage is measured. If the battery in use is low, following the MXD1210 recovery period, the device issues a warning to the system by inhibiting the second memory cycle. The sequence is as follows:

First access: read memory location n, loc(n) = x

Second access: write memory location n,

loc(n) = complement (x)

Third access: read memory location n, loc(n) = ?

If the third access (read) is complement (x), then the battery is good; otherwise the battery is not good. Return to loc(n) = x following the test sequence.

Freshness-Seal Mode

The freshness-seal mode relates to battery longevity during storage rather than directly to battery backup. This mode is activated when the first battery is connected, and is defeated when the voltage at V_{CCI} first exceeds V_{CCTP}. In the freshness-seal mode, both batteries are isolated from the system; that is, no current is drained from either battery, and the RAM is not powered by either battery. This means that batteries can be installed and the system can be held in inventory without battery discharge. The positive edge rate at VBATT1 and VBATT2 should exceed 0.1V/ μ s. The batteries will maintain their full shelf life while installed in the system.

Battery Backup

The *Typical Operating Circuit* shows the MXD1210 connected to write-protect the RAM when V_{CC} is less than 4.75V, and to provide battery backup to the supply.

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Figure 2. Power-Up Timing Diagram

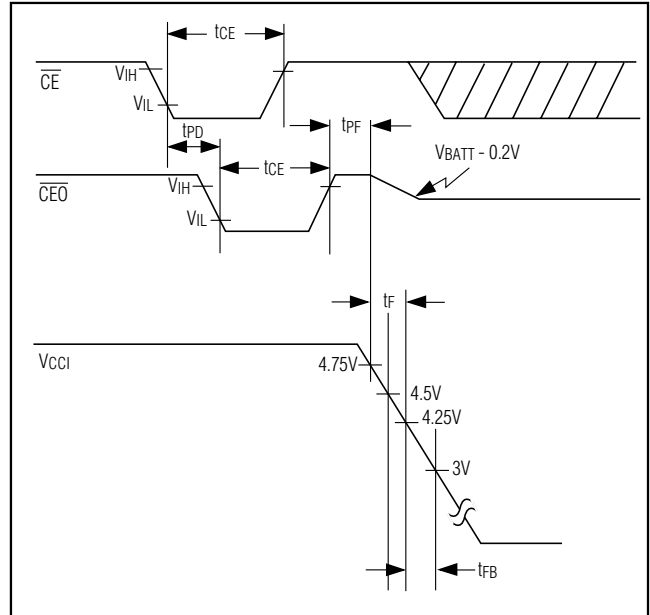


Figure 3. Power-Down Timing Diagram

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MXD1210

Chip Topography



TRANSISTOR COUNT: 1436;
LEAVE SUBSTRATE UNCONNECTED.

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Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to www.maxim-ic.com/packages.)



TOP VIEW



FRONT VIEW



SIDE VIEW

| DIM | INCHES | | MILLIMETERS | |
|-----|-----------|-------|-------------|------|
| | MIN | MAX | MIN | MAX |
| A | 0.053 | 0.069 | 1.35 | 1.75 |
| A1 | 0.004 | 0.010 | 0.10 | 0.25 |
| B | 0.014 | 0.019 | 0.35 | 0.49 |
| C | 0.007 | 0.010 | 0.19 | 0.25 |
| e | 0.050 BSC | | 1.27 BSC | |
| E | 0.150 | 0.157 | 3.80 | 4.00 |
| H | 0.228 | 0.244 | 5.80 | 6.20 |
| L | 0.016 | 0.050 | 0.40 | 1.27 |

VARIATIONS:

| DIM | INCHES | | MILLIMETERS | | N | MS012 |
|-----|--------|-------|-------------|-------|----|-------|
| | MIN | MAX | MIN | MAX | | |
| D | 0.189 | 0.197 | 4.80 | 5.00 | 8 | AA |
| D | 0.337 | 0.344 | 8.55 | 8.75 | 14 | AB |
| D | 0.386 | 0.394 | 9.80 | 10.00 | 16 | AC |

NOTES:

1. D&E DO NOT INCLUDE MOLD FLASH.
2. MOLD FLASH OR PROTRUSIONS NOT TO EXCEED 0.15mm (.006").
3. LEADS TO BE COPLANAR WITHIN 0.10mm (.004").
4. CONTROLLING DIMENSION: MILLIMETERS.
5. MEETS JEDEC MS012.
6. N = NUMBER OF PINS.

| | | |
|-----------------------------|-----------------------------|--------------|
| | DALLAS SEMICONDUCTOR | MAXIM |
| PROPRIETARY INFORMATION | | |
| TITLE: | | |
| PACKAGE OUTLINE, .150" SOIC | | |
| APPROVAL | DOCUMENT CONTROL NO. | REV. |
| | 21-0041 | B 1/1 |

SOICN.EPS

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Package Information (continued)

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MXD1210



PACKAGE FAMILY OUTLINE: PDIP .300"

1/1

21-0043 D
DOCUMENT CONTROL NUMBER REV

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